Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|---|
| 10516818 | TANAKA ET AL. |
| Examiner | Art Unit |
| David M Naff | 1657 |

| SEARCHED | | | | | |
|----------|----------|------|----------|--|--|
| Class | Subclass | Date | Examiner | | |
| | | | | | |

| SEARCH NOTES | | | | |
|-------------------------|--------|----------|--|--|
| Search Notes | Date | Examiner | | |
| West-see search history | 8/1/08 | DMN | | |

| INTERFERENCE SEARCH | | | | |
|---------------------|----------|------|----------|--|
| Class | Subclass | Date | Examiner | |
| | | | | |

U.S. Patent and Trademark Office Part of Paper No.: 20080801